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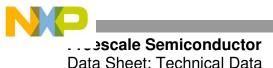
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Document Number: MMA51xxLW Rev. 1, 03/2014

VRoHS



Xtrinsic MMA51xxLW PSI5 Inertial Sensor

The MMA51xxLW family, a SafeAssure solution, includes the AKLV27 and PSI5 Version 1.3 compatible overdamped Z-axis satellite accelerometers.

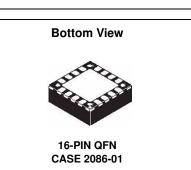
Features

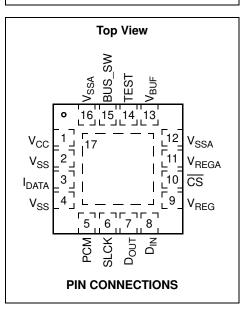
- ±60g to ±480g Full-Scale Range
- · Selectable 400 Hz, 3-Pole, or 4-pole Low-Pass Filter
- · Single Pole High Pass Filter with Fast Startup and Output Rate Limiting
- PSI5 Version 1.3 Compatible
 - PSI5-P10P-500/3L Compatible
 - Programmable Time Slots with 0.5 μs Resolution
 - Selectable Baud Rate: 125 kBaud or 190.5 kBaud
 - Selectable Data Length: 8 or 10 bits
 - Selectable Error Detection: Even Parity, or 3-bit CRC
 - Optional Daisy Chain with External Low-Side Switch
- Two-Wire Programming Mode
- + 16 μs Internal Sample Rate, with Interpolation to 1 μs
- Pb-Free 16-Pin QFN, 6 x 6 Package
- Qualified AECQ100, Revision G, Grade 1 (-40°C to +125°C) (<u>http://www.aecouncil.com/</u>)

Typical Applications

Airbag Front and Side Crash Detection

| | OF | DERING INFO | RMATION | |
|-------------|------|-------------|---------|-------------|
| Device | Axis | Range | Package | Shipping |
| MMA5106LW | Z | ±60g | 2086-01 | Tubes |
| MMA5112LW | Z | ±120g | 2086-01 | Tubes |
| MMA5124LW | Z | ±240g | 2086-01 | Tubes |
| MMA5148LW | Z | ±480g | 2086-01 | Tubes |
| MMA5106LWR2 | Z | ±60g | 2086-01 | Tape & Reel |
| MMA5112LWR2 | Z | ±120g | 2086-01 | Tape & Reel |
| MMA5124LWR2 | Z | ±240g | 2086-01 | Tape & Reel |
| MMA5148LWR2 | Z | ±480g | 2086-01 | Tape & Reel |









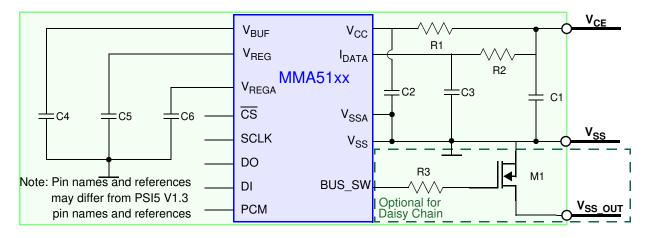
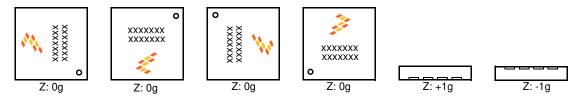


Figure 1. Application Diagram

Table 1. External Component Recommendations

| Ref Des | Туре | Description | Purpose | | | |
|--------------------|--|-------------------------------|--|--|--|--|
| C1 | Ceramic | 2.2 nF, 10%, 50V minimum, X7R | V _{CC} Power Supply Decoupling and Signal Damping | | | |
| C3 | Ceramic 470 pF, 10%, 50V minimum, X7R | | IDATA Filtering and Signal Damping | | | |
| C2 | 2 Ceramic 15 nF, 10%, 50V minimum, X7R | | V _{CC} Power Supply Decoupling | | | |
| C4, C5, C6 | Ceramic | 1 µF, 10%, 10V minimum, X7R | Voltage Regulator Output Capacitor(s) | | | |
| R1 | General Purpose | 82Ω, 5%, 200 PPM | V _{CC} Filtering and Signal Damping | | | |
| R2 | General Purpose | 27Ω, 5%, 200 PPM | IDATA Filtering and Signal Damping | | | |
| R3 General Purpose | | 20 kΩ, 5%, 200 PPM | Gate Resistor for External Low-Side Daisy Chain FET | | | |
| M1 | N-Channel MOSFET | _ | Low-Side Daisy Chain Transistor | | | |



EARTH GROUND

Figure 2. Device Orientation Diagram



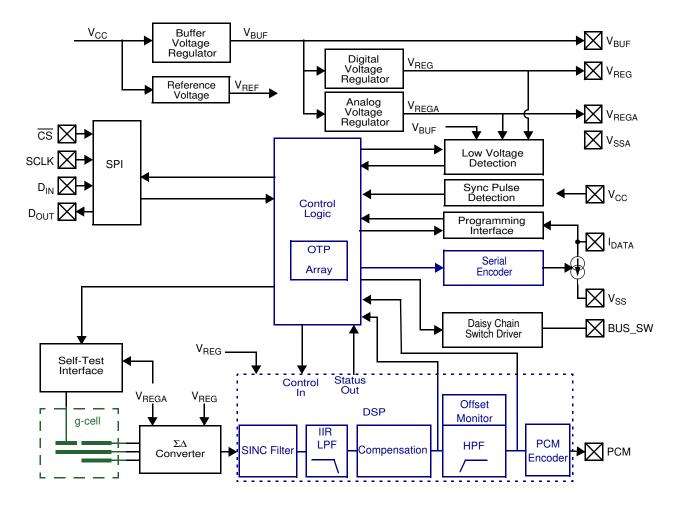


Figure 3. Internal Block Diagram



1 Pin Connections

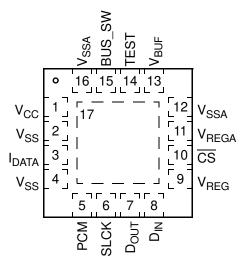


Figure 4. Top View, 16-Pin QFN Package

Table 2. Pin Description

| Pin | Pin Name | Formal Name | Definition |
|-----|-------------------|--------------------------|--|
| 1 | V _{CC} | Supply | This pin is connected to the PSI5 power and data line through a resistor and supplies power to the device. An external capacitor must be connected between this pin and V_{SS} . Reference Figure 1. |
| 2 | V _{SS} | Digital GND | This pin is the power supply return node for the digital circuitry. |
| 3 | I _{DATA} | Response Current | This pin is connected to the PSI5 power and data line through a resistor and modulates the response current for PSI5 com- munication. Reference Figure 1. |
| 4 | V _{SS} | Digital GND | This pin is the power supply return node for the digital circuitry. |
| 5 | РСМ | PCM Output | This pin provides a 4 MHz PCM signal proportional to the acceleration data for test purposes. The output can be enabled via OTP. Reference Section 3.5.3.7. If unused, this pin must be left unconnected. |
| 6 | SCLK | SPI Clock | This input pin provides the serial clock to the SPI port for test purposes. An internal pulldown device is connected to this pin. This pin must be grounded or left unconnected in the application. |
| 7 | D _{OUT} | SPI Data Out | This pin functions as the serial data output from the SPI port for test purposes. This pin must be left unconnected in the appli- cation. |
| 8 | D _{IN} | SPI Data In | This pin functions as the serial data input to the SPI port for test purposes. An internal pulldown device is connected to this pin. This pin must be grounded or left unconnected in the application. |
| 9 | V _{REG} | Digital Supply | This pin is connected to the power supply for the internal digital circuitry. An external capacitor must be connected between this pin and V_{SS} . Reference Figure 1. |
| 10 | CS | Chip Select | This input pin provides the chip select to the SPI port for test purposes. An internal pullup device is connected to this pin. This pin must be left unconnected in the application. |
| 11 | V _{REGA} | Analog Supply | This pin is connected to the power supply for the internal analog circuitry. An external capacitor must be connected between this pin and V_{SSA} . Reference Figure 1. |
| 12 | VSSA | Analog GND | This pin is the power supply return node for the analog circuitry. |
| 13 | V _{BUF} | Power Supply | This pin is connected to a buffer regulator for the internal circuitry. The buffer regulator supplies both the analog (V_{REGA}) and digital (V_{REG}) supplies to provide immunity from EMC and supply dropouts on V_{CC} . An external capacitor must be connected between this pin and V_{SS} . Reference Figure 1. |
| 14 | TEST | Test Pin | This pin is must be grounded or left unconnected in the application. |
| 15 | BUS_SW | Bus Switch Gate Drive | This pin is the drive for a low-side daisy chain switch. When daisy chain mode is enabled, this pin is connected to the gate of an n-channel FET which connects V_{SS} to $V_{SS_{OUT}}$. Reference Figure 1. If unused, this pin must be left unconnected. |
| 16 | VSSA | Analog GND | This pin is the power supply return node for the analog circuitry. |
| 17 | PAD | Die Attach Pad | This pin is the die attach flag, and is internally connected to VSS. Reference Section 7 for die attach pad connection details. |
| | Corner Pads | Corner Pads | The corner pads are internally connected to V _{SS} . |



2 Electrical Characteristics

2.1 Maximum Ratings

Maximum ratings are the extreme limits to which the device can be exposed without permanently damaging it.

| | | | | | 1 |
|---------------------|--|--|---------------------------------|------------------|--------------------------|
| # | Rating | Symbol | Value | Unit | |
| 1 2 3 | Supply Voltage (V _{CC} , I _{DATA}) Reverse Current \leq 160 mA, t \leq 80 ms Continuous Transient (< 10 μs) | V _{CC_REV} V _{CC_MAX} V _{CC_TRANS} | -0.7 +20.0 +25.0 | V V V | (3) (3) (9) |
| 4 | V _{BUF,} Test, BUS_SW | | -0.3 to +4.2 | V | (3) |
| 5 | V _{REG} , V _{REGA,} SCLK, CS, D _{IN} , D _{OUT} , PCM | | -0.3 to +3.0 | V | (3) |
| 6 | Powered Shock (six sides, 0.5 ms duration) | 9 _{pms} | ±2000 | g | (3) |
| 7 | Unpowered Shock (six sides, 0.5 ms duration) | 9 _{shock} | ±2500 | g | (3) |
| 8 | Drop Shock (to concrete, tile or steel surface, 10 drops, any orientation) | h _{DROP} | 1.2 | m | (5) |
| 9 10 11 12 | Electrostatic Discharge (per AEC-Q100) External Pins (V _{CC} , I _{DATA} , V _{SS} , V _{SSA}), HBM (100 pF, 1.5 k Ω) HBM (100 pF, 1.5 k Ω) CDM (R = 0 Ω) MM (200 pF, 0 Ω) | V _{ESD} V _{ESD} V _{ESD} V _{ESD} | ±4000 ±2000 ±1500 ±200 | V V V V | (5) (5) (5) (5) |
| 13 14 | Temperature Range Storage Junction | T _{stg} T _J | -40 to +125 -40 to +150 | °C °C | (3) (9) |
| 15 | Thermal Resistance | θ _{JC} | 2.5 | °C/W | (9,14 |

2.2 Operating Range

 $V_L \le (V_{CC} - V_{SS}) \le V_H$, $T_L \le T_A \le T_H$, $\Delta T \le 25$ K/min, unless otherwise specified.

| # | Characteristic | Symbol | Min | Тур | Мах | Units | |
|----------|--|---------------------------------------|--|-----|--|----------|----------|
| 16 17 | Supply Voltage | V _{CC} V _{CC_UV} | V _L 4.2 V _{VCC_UV_F} | | V _H 17.0 V _L | v v | (1 (9 |
| 18 | Programming Voltage ($I_{DATA} \le 85 \text{ mA}$) Applied to I_{DATA} , V_{CC} | V _{PP} | 14.0 | _ | _ | v | (3 |
| 19 20 | Operating Temperature Range | T _A T _A | T _L -40 -40 | | T _H +105 +125 | °C °C | (1 (3 |



| # | Characteristic | Symbol | Min | Тур | Max | Units | |
|----------------------|---|---|------------------------------|--------------------------------------|--------------------------------|------------------|--------------------------------------|
| 21 | Quiescent Supply Current * | I _{IDLE} | 4.0 | _ | 8.0 | mA | (1) |
| 22 | Modulation Supply Current * | I _{MOD} | I _{IDLE} + 22.0 | I _{IDLE} + 26.0 | I _{IDLE} + 30.0 | mA | (1) |
| 23 | Inrush Current (Power On until V_{BUF} , V_{REG} , V_{REGA} Stable) | I _{INRUSH} | — | — | 30 | mA | (3) |
| 24 25 26 | Internally Regulated Voltages VBUF VREG VREGA * | V _{BUF} V _{REG} V _{REGA} | 3.60 2.425 2.425 | 3.80 2.50 2.50 | 4.00 2.575 2.575 | V V V | (1) (1) (1) |
| 27 28 29 30 | Low Voltage Detection Threshold V _{CC} Falling V _{BUF} Falling V _{REG} Falling V _{REGA} Falling Hysteresis | V _{VCC_UV_F} V _{BUF_UV_F} V _{REG_UV_F} V _{REGA_UV_F} | 3.40 2.95 2.15 2.15 | 3.70 3.15 2.25 2.25 | 4.0 3.35 2.35 2.35 | V V V V | (3, 6) (3, 6) (3, 6) (3, 6) |
| 31 32 33 34 | V _{CC} V _{BUF} V _{REG} V _{REGA} | V _{CC_HYST} Vbuf_hyst Vreg_hyst Vrega_hyst | 0.10 0.05 0.05 0.05 | 0.25 0.10 0.10 0.10 | 0.40 0.15 0.15 0.15 | V V V V | (3) (3) (3) (3) |
| 35 36 | External Capacitor (V _{BUF} , V _{REG} , V _{REGA}) Capacitance ESR (including interconnect resistance) | ESR | 500 0 | 1000 — | 1500 200 | nF mΩ | (9) (9) |
| 37 38 | Synchronization Pulse (See Figure 5) V _{IDLE} Voltage Range * DC Sync Pulse Detection Threshold * | V _{IDLE} ΔV _{SYNC} | V _{IDLE} +1.4 | V _{IDLE} +2.0 | 15.4 V _{IDLE} +2.6 | V V | (3, 11 (3, 6 |
| 39 | Sync Pulse Pulldown Current | I _{SYNC_PD} | — | I _{MOD} - I _{IDLE} | — | mA | (3) |
| 40 | Output High Voltage (DO) I _{Load} = 100 μA | V _{OH} | V _{REG} - 0.1 | _ | — | v | (9) |
| 41 | Output Low Voltage (DO) I _{Load} = 100 μA | V _{OL} | _ | _ | 0.1 | v | (9) |
| 42 | Input <u>Hig</u> h Voltage CS, SCLK, DI | V _{IH} | 0.7 * V _{REG} | _ | _ | v | (9) |
| 43 | Input <u>Lo</u> w Voltage CS, SCLK, DI | V _{IL} | _ | _ | 0.3 * V _{REG} | v | (9) |
| 44 45 | Input Current High (at V _{IH}) <u>(DI)</u> Low (at V _{IL}) (CS) | I _{IH} I _{IL} | -100 10 | | -10 100 | μΑ μΑ | (9) (9) |
| 46 | Pulldown Resistance (SCLK) | R _{PD} | 20 | — | 100 | kΩ | (9) |
| 47 | BUS_SW Output High Voltage (BUS_SW) $I_{Load} = 100 \ \mu A$ | V _{BUS_SW_OH} | 3.15 | _ | V _{BUF} | v | (9) |
| 48 | Output Low Voltage (BUS_SW) I _{Load} = 100 μA | V _{BUS_SW_OL} | 0.0 | _ | 0.45 | v | (9) |
| 49 | Daisy Chain Addressing Mode Sync Pulse Period | | | t _{S-S_PM_L} | _ | S | (7) |
| 50 | Bus Switch Output Activation Time (C = 50 pF) From last bit of "SetAdr" Response to 80% of V _{BUS_SW_OH} | t _{BUS_} SW | _ | _ | 300 | μs | (7) |
| 51 | Sync Pulse Blanking Time after "SetAdr" Command Received From last bit of "SetAdr" Response | ^t DC_BLANKING | | 200000 / f _{OSC} | | s | (7) |



| # | Characteristic | | Symbol | Min | Тур | Мах | Units | Ī |
|----------------------------------|--|-------|--|----------------------------------|------------------|----------------------------------|----------------------------------|--|
| 52 53 54 55 | Sensitivity (10-bit output @ 100 Hz, referenced to 0 Hz) ±60g Range ±120g Range ±240g Range ±480g Range | * * * | SENS SENS SENS SENS | | 8 4 2 1 | | LSB/g LSB/g LSB/g LSB/g | (1) (1) (1) (1) |
| 56 57 58 59 60 61 | $ \begin{array}{l} \mbox{Total Sensitivity Error (including non-linearity)} \\ T_A = 25^\circ C, \le \pm 240 g \\ T_L \le T_A \le T_H, \le \pm 240 g \\ T_L \le T_A \le T_H, \le \pm 240 g, \ V_{VCC_UV_F} \le V_{CC} \le V_L \\ T_A = 25^\circ C, > \pm 240 g \\ T_L \le T_A \le T_H, > \pm 240 g \\ T_L \le T_A \le T_H, > \pm 240 g, \ V_{VCC_UV_F} \le V_{CC} \le V_L \\ \end{array} $ | * * * | ΔSENS_240 ΔSENS_240 ΔSENS_240 ΔSENS_480 ΔSENS_480 ΔSENS_480 | -5 -7 -7 -5 -7 -7 | | +5 +7 +7 +5 +7 +7 | % % % % | (1) (1) (9) (1) (1) (9) |
| 62 63 | Digital Offset Before Offset Cancellation 10-bit 10-bit, T _L ≤ T _A ≤ T _H , V _{VCC_UV_F} ≤ V _{CC} ≤ V _L | * | OFF _{10Bit} OFF _{10Bit} | -52 -52 | 0 0 | +52 +52 | LSB LSB | (1) (9) |
| 64 65 | Digital Offset After Offset Cancellation 10-bit, 0.3 Hz HPF or 0.1 Hz HPF 10-bit, 0.04 Hz HPF | * | OFF _{10Bit} OFF _{10Bit} | -1 -2 | 0 0 | +1 +2 | LSB LSB | (1) (9) |
| 66 | Continuous Offset Monitor Limit 10-bit output, before compensation | | OFF _{MON} | -66 | _ | +66 | LSB | (3) |
| 67 | Range of Output (10-Bit Mode) Acceleration | | RANGE | -480 | _ | +480 | LSB | (3) |
| 68 69 | Cross-Axis Sensitivity X-axis to Z-Axis Y-axis to Z-Axis | * | V _{XZ} V _{YZ} | -5 -5 | _ | +5 +5 | % % | (3) (3) |
| 70 | System Output Noise Peak (10-bit Mode, 1 Hz - 1 kHz, All Ranges) | * | n _{Peak} | -4 | - | +4 | LSB | (3) |
| 71 | System Output Noise RMS (10-bit mode, 1 Hz - 1 kHz, All Ranges) | * | n _{RMS} | — | — | +1.0 | LSB | (3) |
| 72 73 | Non-linearity 10-bit output, ≤ ±240g 10-bit output, > ±240g | | NL _{OUT_240g} NL _{OUT_480g} | -2 -2 | | +2 +2 | % % | (3) (3) |



2.5 Electrical Characteristics - Self-Test and Overload

 $V_L \leq (V_{CC} \text{ - } V_{SS}) \leq V_H, \, T_L \leq T_A \leq T_H, \, \Delta T \leq 25 \text{ K/min, unless otherwise specified.}$

| # | Characteristic | Symbol | Min | Тур | Max | Units | |
|----------------------|--|--|-----------------------|---------------|-------------------------|--------------------------|--------------------------|
| 74 75 76 77 | | 9st10_60z 9st10_120z 9st10_240z 9st10_480z | 120 40 35 12 | | 280 160 153 94 | LSB LSB LSB LSB | (3) (3) (3) (3) |
| 78 79 | Acceleration (without hitting internal g-cell stops) ±60g Range Positive ±60g Range Negative | 9g-cell_Clip60ZP 9g-cell_Clip60ZN | 425 -1205 | 642 -720 | 980 -512 | g g | (9) (9) |
| 80 81 | Acceleration (without hitting internal g-cell stops) ±120g Range Positive ±120g Range Negative | 9g-cell_Clip120ZP 9g-cell_Clip120ZN | 425 -1205 | 642 -720 | 980 -512 | g g | (9) (9) |
| 82 83 | Acceleration (without hitting internal g-cell stops) ±240g Range Positive ±240g Range Negative | 9 _{g-cell_} Clip240ZP 9 _g -cell_Clip240ZN | 1450 -3100 | 2180 -2210 | 2800 -1800 | g g | (9) (9) |
| 84 85 | Acceleration (without hitting internal g-cell stops) ±480g Range Positive ±480g Range Negative | 9 _{g-cell_} Clip480ZP 9 _g -cell_Clip480ZN | 2200 -3700 | 2800 -3220 | 3300 -2780 | g g | (9) (9) |
| 86 87 | Σ∆ and Sinc Filter Clipping Limit ±60g Range Positive ±60g Range Negative | 9adc_clip60ZP 9adc_clip60ZN | 159 -334 | 238 -274 | 336 -216 | g g | (9) (9) |
| 88 89 | $\Sigma\Delta$ and Sinc Filter Clipping Limit ±120g Range Positive ±120g Range Negative | 9ADC_Clip120ZP 9ADC_Clip120ZN | 305 -693 | 433 -544 | 577 -414 | g g | (9) (9) |
| 90 91 | $\Sigma\Delta$ and Sinc Filter Clipping Limit ±240g Range Positive ±240g Range Negative | 9ADC_Clip240ZP 9ADC_Clip240ZN | 836 -1909 | 1178 -1566 | 1599 -1245 | g g | (9) (9) |
| 92 93 | Σ∆ and Sinc Filter Clipping Limit ±480g Range Positive ±480gZ Range Negative | 9ADC_Clip480ZP 9ADC_Clip480ZN | 1591 -3217 | 2014 -2856 | 2478 -2524 | g g | (9) (9) |



2.6 Dynamic Electrical Characteristics - PSI5 $V_L \leq (V_{CC} - V_{SS}) \leq V_H, T_L \leq T_A \leq T_H, \Delta T \leq 25$ K/min, unless otherwise specified

| # | Characteristic | | Symbol | Min | Тур | Мах | Units |] |
|--|---|---|--|--|--|--|--|--|
| 94 95 96 97 98 99 100 101 102 103 104 105 106 107 108 109 | Initialization Timing Phase 1 Phase 2 (10-Bit, Synchronous Mode, k = 4) Phase 2 (8-Bit, Synchronous Mode 0, k = 8) Phase 2 (8-Bit, Asynchronous Mode 0, k = 8) Phase 2 (8-Bit, Asynchronous Mode 0, k = 16) Phase 3 (10-Bit, Synchronous Mode, ST_RPT = 0) Phase 3 (8-Bit, Synchronous Mode 0, ST_RPT = 0) Phase 3 (8-Bit, Asynchronous Mode 0, ST_RPT = 0) Phase 3 (8-Bit, Asynchronous Mode 0, ST_RPT = 0) Phase 3 (8-Bit, Asynchronous Mode 0, ST_RPT = 0) Offset Cancellation Stage 1 Operating Time Offset Cancellation Stage 2 Operating Time Self-Test Stage 1 Operating Time Self-Test Stage 3 Operating Time Self-Test Repetitions Programming Mode Entry Window | | [†] PSI5_INIT1 †PSI5_INIT2_10s †PSI5_INIT2_10a0 †PSI5_INIT2_10a0 †PSI5_INIT2_10a0 †PSI5_INIT3_10s †PSI5_INIT3_8s †PSI5_INIT3_8a0 †PSI5_INIT3_8a0 †PSI5_INIT3_8a0 †OC1 †OC2 †ST1 †ST2 tST3 ST_RPT †PME | | 532000 / fosc 256 * ts-s 288 * ts-s 512 * tAsYNC 576 * tASYNC 2 * ts-s 2 * ts-s 19 * tASYNC 320000 / fosc 128000 / fosc 128000 / fosc 128000 / fosc 128000 / fosc 300000 / fosc | | \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ \$ | (7) (7) (7) (7, 12) (7, 12) (7, 12) (7, 12) (7, 12) (7, 12) (7) (7) (7) (7) (7) (7) (7) (7) (7) (7 |
| 110 111 112 113 114 115 116 117 118 119 120 121 | Synchronization Pulse (Figure 5, Figure 28 and Figure 32) Reset to first sync pulse (Program Mode Entry) Reset to first sync pulse (Normal Mode) Sync Pulse Period Sync Pulse Width Sync Pulse Reference LPF time constant Sync Pulse Reference Discharge Start Time Sync Pulse Reference Discharge Activation Time Sync Pulse Detection Disable Time (BLANKTIME = 0) Analog Delay of Sync Pulse Detection Sync Pulse Pulldown Function Delay Time Sync Pulse Pulldown Function Activate Time Sync Pulse Detection Jitter | | trs_pm trs ts-s tsync_lpf tsync_lpf_rst_st tsync_lpf_rst_st tsync_off_500 ta_sync_Dly tpD_Dly tpD_ON tsync_jit | 58 tpsi5_init1 tsync_off 9 120 — — 50 — 0 | | | ms s μs μs s s ns s s s s s | (7) (7) (7) (7) (7) (7) (7) (7) (7) (7) |
| 122 123 | Data Transmission Single Bit Time (PSI5 Low Bit Rate) Data Transmission Single Bit Time (PSI5 High Bit Rate) | * | ^t віт_low t _{віт_ні} | 7.6000 4.9875 | 8.0000 5.2500 | 8.4000 5.5125 | μs μs | (7) (7) |
| 124 125 | Modulation Current (20% to 80% of I _{MOD} - I _{IDLE}) Rise Time Fall Time | | ^t rise ^t fall | 324 324 | 463 463 | 602 602 | ns ns | (3) (3) |
| 126 127 | Position of bit transition (PSI5 Low Baud Rate) Position of bit transition (PSI5 High Baud Rate) | * | t _{Bittrans_LowBaud} t _{Bittrans_HighBaud} | 49 47 | 50 | 51 53 | % % | (7) (7) |
| 128 | Asynchronous Response Time | * | t _{ASYNC} | | 912 / f _{OSC} | — | S | (7) |
| 129 130 131 132 133 134 135 136 | Time Slots Minimum Programmed Time Slot (TIMESLOTx = 0x001) Maximum Programmed Time Slot (TIMESLOTx = 0x3FF) Default Time Slot (TIMESLOTx = 0x000) Time Plot Resolution Sync Pulse to Daisy Chain Default Time Slot 1 Sync Pulse to Daisy Chain Default Time Slot 2 Sync Pulse to Daisy Chain Default Time Slot 3 Sync Pulse to Daisy Chain Programming Time Slot | * | ^t TIMESLOTx_MIN ^t TIMESLOT_DFLT ^t TIMESLOT_DFLT ^t TIMESLOT_RES ^t TIMESLOT_DC1 ^t TIMESLOT_DC2 ^t TIMESLOT_DC3 ^t TIMESLOT_DCP | | 2 / fosc 2046 / fosc 2 / fosc 2 / fosc 186 / fosc 186 / fosc 1400 / fosc 186 / fosc | | s s s/LSB s s s s | (7, 9) (3, 7) (3, 7) (7) (7) (7) (7) (7) (7) |
| 137 138 139 140 | Data Interpolation Latency (Figure 35, Figure 36) Data Setup Time - Synchronous Mode (Figure 36) Data Setup Time - Double Sample Rate Mode (Figure 37) Data Setup Time - 16 Bit Resolution Mode (Figure 39) | | ^t LAT_INTERP ^t DATASETUP_synch ^t DATASETUP_double ^t DATASETUP_16 | 64 / f _{OSC} 48 / f _{OSC} 48 / f _{OSC} 48 / f _{OSC} | | 65 / f _{OSC} 56 / f _{OSC} 60 / f _{OSC} 60 / f _{OSC} | S S S | (7) (7) (7) (7) |
| 141 142 143 144 145 | Programming Mode Timing Programming Mode Sync Pulse Period Programming Mode Command Timeout OTP Write Command to $V_{CC} = V_{PP}$ OTP Write CMD Response to OTP programming start Time to program the OTP User Array | | [†] S-S_PM_L [†] PM_TIMEOUT [†] PROG_HOLD [†] PROG_DELAY [†] PROG_ARRAY | 495 — — — 70 | 500 4 * t _{S·S_PM} — — | 505 — 20 40 — | μs μs ms ms | (7) (7) (7) (7) (7) |



2.7 Dynamic Electrical Characteristics - Signal Chain $V_L \leq (V_{CC} - V_{SS}) \leq V_H, T_L \leq T_A \leq T_H, \Delta T \leq 25$ K/min, unless otherwise specified

| # | Characteristic | Symbol | Min | Тур | Max | Units | |
|--|--|---|----------------------------------|--|----------------------------------|---|--|
| 146 | Internal Oscillator Frequency * | fosc | 3.80 | 4 | 4.20 | MHz | (1) |
| 147 148 149 150 | DSP Low-Pass Filter (Note15) Cutoff frequency LPF0 (referenced to 0 Hz) Filter Order LPF0 Cutoff frequency LPF1 (referenced to 0 Hz) Filter Order LPF1 * | f _{C_LPF0} O _{LPF0} f _{C_LPF1} O _{LPF1} | | 400 3 400 4 | | Hz 1 Hz 1 | (7) (7) (7) (7) |
| 151 152 153 154 155 156 157 158 159 160 161 162 163 164 | DSP Offset Cancellation Low-Pass Filter (Note15) Offset Cancellation Low-Pass Filter Input Sample Rate Stage 1 Cutoff frequency, Startup Phase 1 Stage 2 Cutoff frequency, Startup Phase 1 Stage 2 Cutoff frequency, Startup Phase 1 Cutoff frequency, Option 0 Filter Order, Option 0 Offset Cancellation Output Update Rate (8-Bit Mode) Offset Cancellation Output Step Size (8-Bit Mode) Offset Cancellation Output Update Rate (10-Bit Mode) Offset Cancellation Output Step Size (10-Bit Mode) Offset Cancellation Output Step Size (10-Bit Mode) Offset Monitor Update Frequency Offset Monitor Count Limit Offset Monitor Counter Size | ^t OC_SampleRate fc_OC10 OOC10 fc_OC03 fc_OC03 fc_OC0 OCC0 tOffRate_8 OFFStep_8 toffRate_10 OFFStep_10 OFFMON _{CNTLIMIT} OFFMON _{CNTSIZE} | | $\begin{array}{c} 256\\ 10.0\\ 1\\ 0.300\\ 1\\ 0.100\\ 1\\ f_{OSC}/2e6\\ 0.125\\ f_{OSC}/2e6\\ 0.5\\ f_{OSC}/2000\\ 4096\\ 8192 \end{array}$ | | μs Hz 1 Hz 1 S S LSB Hz 1 1 | (7) (7) (7) (7) (7) (7) (7) (7) (7) (7) |
| 165 166 167 168 | Sensing Element Natural Frequency ±60g ±120g ±240g ±480g | ^f gcell_Z60 fgcell_Z120 fgcell_Z240 fgcell_Z240 fgcell_Z480 | 7000 7000 13600 16289 | | 8000 8000 15100 17996 | Hz Hz Hz Hz | (9) (9) (9) (9) |
| 169 170 171 172 | Sensing Element Roll-off Frequency (-3 db) ±60g ±120g ±240g ±480g | ^f gcell_Z60 f _g cell_Z120 f _g cell_Z240 f _g cell_Z480 | 798 798 2000 2250 | | 2211 2211 4700 6350 | Hz Hz Hz Hz | (9) (9) (9) (9) |
| 173 174 175 176 | Sensing Element Damping Ratio ±60g ±120g ±240g ±480g | ζgcell_Z60 Sgcell_Z120 Sgcell_Z240 Sgcell_Z480 | 1.870 1.870 1.750 1.250 | | 4.610 4.610 3.500 3.000 | | (9) (9) (9) (9) |
| 177 178 179 180 | Sensing Element Delay (@100 Hz) <u>+6</u> 0g ±120g ±240g ±480g | ^f gcell_delay_Z60 ^f gcell_delay_Z120 ^f gcell_delay_Z240 ^f gcell_delay_Z480 | 77 77 40 21 | | 200 200 86 60 | μs μs μs μs | (9) (9) (9) (9) |
| 181 | Package Resonance Frequency | f _{Package} | 100 | — | _ | kHz | (9) |



2.8 Dynamic Electrical Characteristics - Supply and SPI

 $V_L \le (V_{CC} - V_{SS}) \le V_H$, $T_L \le T_A \le T_H$, $\Delta T \le 25$ K/min, unless otherwise specified

| # | Characteristic | Symbol | Min | Тур | Max | Units |] |
|---|---|---|--|--|-------------|--|----------------|
| 182 | Quiescent Current Settling Time (Power Applied to $Iq = I_{IDLE} \pm 2 mA$) | t _{SET} | _ | — | 5 | ms | (|
| 183 | Reset Recovery Internal Delay (After internal POR) | t _{INT_INIT} | — | 16000 / f _{OSC} | | S | (|
| 184 185 186 | $\label{eq:VCC} \begin{array}{l} V_{CC} \mbox{ Micro-cut} \left(C_{BUF} \!\!=\! C_{REG} \!\!=\! C_{REGA} \!\!=\! 1 \mu F \right) \\ \mbox{ Survival Time} \left(V_{CC} \mbox{ disconnect without Reset, } C_{BUF} \!\!=\! C_{REG} \!\!=\! C_{REGA} \!\!=\! 700 \mbox{ nF} \right) \\ \mbox{ Survival Time} \left(V_{CC} \mbox{ disconnect without Reset, } C_{BUF} \!\!=\! C_{REG} \!\!=\! C_{REGA} \!\!=\! 1 \mu F \right) \\ \mbox{ Reset Time} \left(V_{CC} \mbox{ disconnect above which Reset is guaranteed} \right) \end{array}$ | ^t vcc_MICROCUTmin ^t vcc_MICROCUT ^t vcc_RESET | 30 50 | | 1000 | μs μs μs | (; (; (; |
| 187 188 189 190 | V _{BUF} , Capacitor Monitor Disconnect Time (Figure 10) POR to first Capacitor Test Disconnect Disconnect Time (Figure 10) Disconnect Delay, Asynchronous Mode (Figure 10) Disconnect Delay, Synchronous Mode (Figure 11) | [†] POR_CAPTEST [†] CAPTEST_TIME [†] CAPTEST_ADLY [†] CAPTEST_SDLY | | 12000 / f _{OSC} 1.5 688 / f _{OSC} 72 / f _{OSC} | 5.0 | s μs s s | (7 (7 (7 |
| 191 192 193 | V _{REG} , V _{REGA} Capacitor Monitor POR to first Capacitor Test Disconnect Disconnect Time Disconnect Rate | ^t POR_CAPTEST ^t CAPTEST_TIME ^t CAPTEST_RATE | | 12000 / f _{OSC} 6 / f _{OSC} 256 / f _{OSC} | | s s | (7 (7 (7 |
| 194 195 196 197 198 200 201 202 203 204 205 206 207 | $ \begin{array}{l} \label{eq:series} \begin{aligned} & \text{Serial Interface Timing (See Figure 7, $C_{\text{DOUT}} \leq 80 \text{ pF}, $R_{\text{DOUT}} \geq 10 \text{ k}\Omega$) \\ & \text{Clock (SCLK) period (10\% of V_{CC} to 10\% of V_{CC}) \\ & \text{Clock (SCLK) high time (90\% of V_{CC} to 90\% of V_{CC}) \\ & \text{Clock (SCLK) low time (10\% of V_{CC} to 10\% of V_{CC}) \\ & \text{Clock (SCLK) low time (10\% of V_{CC} to 10\% of V_{CC}) \\ & \text{Clock (SCLK) rise time (10\% of V_{CC} to 90\% of V_{CC}) \\ & \text{Clock (SCLK) fall time (90\% of V_{CC} to 10\% of V_{CC}) \\ & \text{Clock (SCLK) fall time (90\% of V_{CC} to 10\% of V_{CC}) \\ & \text{CS asserted to SCLK high (CS = 10\% of V_{CC} to SCLK = 10\% of V_{CC}) \\ & \text{Data setup time (D_{\text{IN}} = 10/90\% of V_{CC to SCLK = 100\% of V_{CC}) \\ & \text{Data setup time (SCLK = 90\% of V_{CC to SCLK = 100\% of V_{CC}$) \\ & \text{D}_{\text{OUT}}$ Data hold time (SCLK = 90\% of V_{CC to D_{\text{OUT}} = 10/90\% of V_{CC}$) \\ & \text{SCLK low to } \frac{data valid (SCLK = 10\% of V_{CC to D_{\text{OUT}} = 10/90\% of V_{CC}$) \\ & \text{SCLK low to } \frac{data valid (SCLK = 10\% of V_{CC to CS = 90\% of V_{CC}$) \\ & \frac{SCLK low to CS high (SCLK = 10\% of V_{CC to CS = 90\% of V_{CC}$) \\ & \frac{CS}{\text{ sigh to } D_{\text{OUT}}$ disable (CS = 90\% of V_{CC to CS = 90\% of V_{CC}$) \\ & \frac{CS}{\text{ sigh to CS}} low (CS = 90\% of V_{CC}$ to CS = 90\% of V_{CC}$) \\ & \text{SCLM Low to CS} low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of V_{CC}$) \\ & \text{CS} high to CS low (CS = 90\% of $V_{\text{CC}$$ | tsclk tsclkh tsclkk tsclkk tsclkk tlead taccess tsetup thold_in thold_out tvalid tlag tdsable tcsn | 320 120 120 60 20 10 0 60 1000 | 15 15 | | ns ns ns ns ns ns ns ns ns ns ns ns ns | |

1. Parameters tested 100% at final test.

2. Parameters tested 100% at wafer probe.

3. Verified by characterization.

4. * Indicates critical characteristic.

5. Verified by qualification testing.

6. Parameters verified by pass/fail testing in production.

7. Functionality guaranteed by modeling, simulation and/or design verification. Circuit integrity assured through IDDQ and scan testing. Timing is determined by internal system clock frequency.

8. N/A.

9. Verified by simulation.

10. N/A.

11. Measured at V_{CC} pin; V_{SYNC} guaranteed across full V_{IDLE} range.

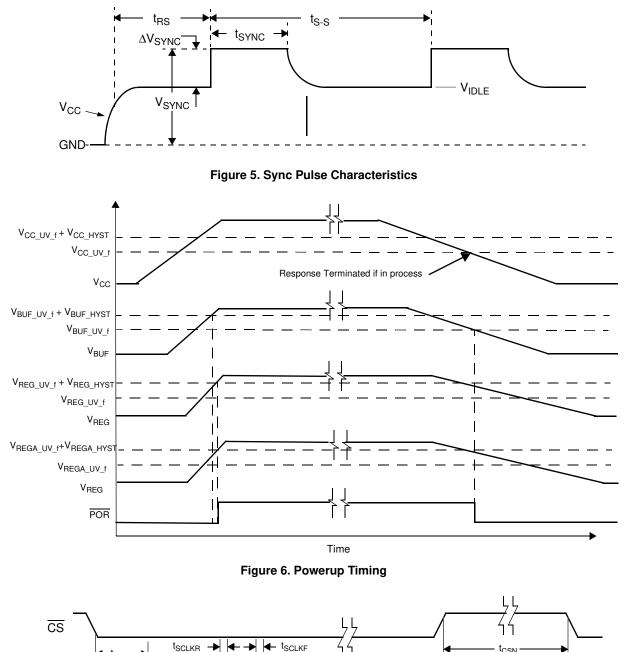
12. Self-Test repeats on failure up to a ST_RPT_{MAX} times before transmitting Sensor Error Message.

13. N/A.

14. Thermal resistance between the die junction and the exposed pad; cold plate is attached to the exposed pad.

15. Filter cutoff frequencies are directly dependent upon the internal oscillator frequency.





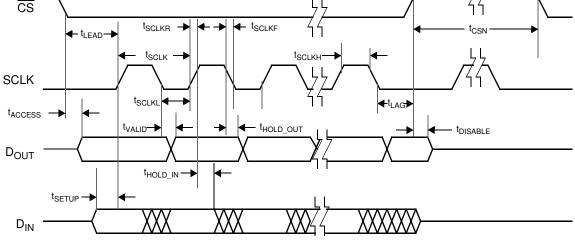


Figure 7. Serial Interface Timing



3 Functional Description

3.1 User Accessible Data Array

A user accessible data array allows for each device to be customized. The array consists of an OTP factory programmable block, an OTP user programmable block, and read only registers for device status. The OTP blocks incorporate independent error detection circuitry for fault detection (reference Section 3.2). Portions of the factory programmable array are reserved for factory-programmed trim values. The user accessible data is shown in Table 3.

| Byte Addr | | Nibble Addr | | Bit Fu | nction | | Nibble Addr | | Bit Fu | nction | | |
|----------------|----------|----------------|--------------|--------------|--------------|--------------|----------------|--------------|--------------|--------------|--------------|------|
| (XLong Msg) | Register | (Long Msg) | 7 | 6 | 5 | 4 | (Long Msg) | 3 | 2 | 1 | 0 | Туре |
| \$00 | SN0 | \$01 | SN[7] | SN[6] | SN[5] | SN[4] | \$00 | SN[3] | SN[2] | SN[1] | SN[0] | |
| \$01 | SN1 | \$03 | SN[15] | SN[14] | SN[13] | SN[12] | \$02 | SN[11] | SN[10] | SN[9] | SN[8] | |
| \$02 | SN2 | \$05 | SN[23] | SN[22] | SN[21] | SN[20] | \$04 | SN[19] | SN[18] | SN[17] | SN[16] | F, R |
| \$03 | SN3 | \$07 | SN[31] | SN[30] | SN[29] | SN[28] | \$06 | SN[27] | SN[26] | SN[25] | SN[24] | |
| \$04 | DEVCFG1 | \$09 | 0 | 0 | 1 | 0 | \$08 | AXIS | RNG[2] | RNG[1] | RNG[0] | |
| \$05 | DEVCFG2 | \$0B | LOCK_U | PCM | SYNC_PD | LATENCY | \$0A | DATASIZE | BLANKTIME | P_CRC | BAUD | |
| \$06 | DEVCFG3 | \$0D | TRANS_MD[1] | TRANS_MD[0] | LPF[1] | LPF[0] | \$0C | TIMESLOTB[9] | TIMESLOTB[8] | TIMESLOTA[9] | TIMESLOTA[8] | |
| \$07 | DEVCFG4 | \$0F | TIMESLOTA[7] | TIMESLOTA[6] | TIMESLOTA[5] | TIMESLOTA[4] | \$0E | TIMESLOTA[3] | TIMESLOTA[2] | TIMESLOTA[1] | TIMESLOTA[0] | |
| \$08 | DEVCFG5 | \$11 | TIMESLOTB[7] | TIMESLOTB[6] | TIMESLOTB[5] | TIMESLOTB[4] | \$10 | TIMESLOTB[3] | TIMESLOTB[2] | TIMESLOTB[1] | TIMESLOTB[0] | U, R |
| \$09 | DEVCFG6 | \$13 | INIT2_EXT | ASYNC | U_DIR[1] | U_DIR[0] | \$12 | U_REV[3] | U_REV[2] | U_REV[1] | U_REV[0] | |
| \$0A | DEVCFG7 | \$15 | MONTH[3] | MONTH[2] | MONTH[1] | MONTH[0] | \$14 | YEAR[3] | YEAR[2] | YEAR[1] | YEAR[0] | |
| \$0B | DEVCFG8 | \$17 | UD[2] | UD[1] | UD[0] | DAY[4] | \$16 | DAY[3] | DAY[2] | DAY[1] | DAY[0] | |
| \$0C | SC | \$19 | 0 | TM_B | RESERVED | IDEN_B | \$18 | OC_INIT_B | IDEF_B | OFF_B | 1 | R |
| \$0D | MFG_ID | \$1B | MFG_ID[7] | MFG_ID[6] | MFG_ID[5] | MFG_ID[4] | \$1A | MFG_ID[3] | MFG_ID[2] | MFG_ID[1] | MFG_ID[0] | U, R |

Table 3. User Accessible Data

Type codes

F: Freescale programmed OTP location

U: User programmable OTP location via PSI5

R: Readable register via PSI5

3.1.1 Device Serial Number Registers

A unique serial number is programmed into the serial number registers of each device during manufacturing. The serial number is composed of the following information:

| Bit Range | Content |
|-----------|---------------|
| SN[12:0] | Serial Number |
| SN[31:13] | Lot Number |

Serial numbers begin at 1 for all produced devices in each lot and are sequentially assigned. Lot numbers begin at 1 and are sequentially assigned. No lot will contain more devices than can be uniquely identified by the 13-bit serial number. Depending on lot size and quantities, all possible lot numbers and serial numbers may not be assigned.

The serial number registers are included in the factory programmed OTP CRC verification. Reference Section 3.2.1 for details regarding the CRC verification. Beyond this, the contents of the serial number registers have no impact on device operation or performance, and are only used for traceability purposes.



3.1.2 Factory Configuration Register (DEVCFG1)

The factory configuration register is a factory programmed, read only register which contains user specific device configuration information. The factory configuration register is included in the factory programmed OTP CRC verification.

| Location | | | Bit | | | | | | |
|-----------------|----------|---|-----|---|---|------|--------|--------|--------|
| Address | Register | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| \$04 | DEVCFG1 | 0 | 0 | 1 | 0 | AXIS | RNG[2] | RNG[1] | RNG[0] |
| Factory Default | | 0 | 0 | 1 | 0 | 1 | 0 | 0 | 0 |

3.1.2.1 Axis Indication Bit (AXIS)

The axis indication bit indicates the axes of sensitivity as shown below. This bit is factory programmed.

| AXIS | Sensitivity Axis |
|------|------------------|
| 0 | Х |
| 1 | Z |

3.1.2.2 Range Indication Bits (RNG[2:0])

The range indication bits are factory programmed and indicate the full-scale range of the device as shown below.

| RNG[2] | RNG[1] | RNG[0] | Full-Scale Acceleration Range | g-Cell Design | PSI5 Init Data Transmission (D9) Reference Table 13 |
|--------|--------|--------|----------------------------------|---------------|---|
| 0 | 0 | 0 | Reserved | N/A | 0001 |
| 0 | 0 | 1 | ±60g | Medium-g | 0111 |
| 0 | 1 | 0 | Reserved | N/A | 0010 |
| 0 | 1 | 1 | ±120g | Medium-g | 1000 |
| 1 | 0 | 0 | Reserved | N/A | 0011 |
| 1 | 0 | 1 | ±240g | High-g | 1001 |
| 1 | 1 | 0 | Reserved | N/A | 0100 |
| 1 | 1 | 1 | ±480g | High-g | 1010 |

3.1.3 Device Configuration 2 Register (DEVCFG2)

Device configuration register 2 is a user programmable OTP register that contains device configuration information.

| Loca | ation | | Bit | | | | | | |
|---------|----------|--------|-----|---------|---------|----------|-----------|-------|------|
| Address | Register | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| \$05 | DEVCFG2 | LOCK_U | PCM | SYNC_PD | LATENCY | DATASIZE | BLANKTIME | P_CRC | BAUD |
| Factory | Default | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

3.1.3.1 User Configuration Lock Bit (LOCK_U)

The LOCK_U bit allows the user to prevent writes to the user configuration array once programming is completed.

If the LOCK_U bit is written to '1' when a PSI5 "Execute Programming of NVM" command is executed, the LOCK_U OTP bit will be programmed. Upon completion of the OTP programming, an OTP readout will be executed, locking the array from future OTP writes. The User Programmable OTP Array Error Detection is also activated (Reference Section 3.2.2).

3.1.3.2 PCM Enable Bit (PCM)

The PCM bit enables the PCM output pin. When the PCM bit is set, the PCM output pin is active and outputs a Pulse Code Modulated signal proportional to the acceleration response. Reference Section 3.5.3.7 for more information regarding the PCM output. When the PCM bit is cleared, the PCM output pin is actively pulled low.



| PCM | PCM Output |
|-----|---------------------|
| 0 | Actively Pulled Low |
| 1 | PCM Signal Enabled |

3.1.3.3 Sync Pulse Pulldown Enable Bit (SYNC_PD)

The sync pulse pulldown enable bit selects if the sync pulse pulldown is enabled once a sync pulse is detected. Reference Section 4.2.1.2 for more information regarding the sync pulse pulldown.

| SYNC_PD | Sync Pulse Pulldown |
|---------|---------------------|
| 0 | Disabled |
| 1 | Enabled |

If Daisy Chain Mode is enabled, the Sync Pulse Pulldown is enabled as listed below:

| SYNC_PD | Daisy Chain Address Programmed | "Run Mode" Command Received | Daisy Chain Address = '001' | Sync Pulse Pulldown |
|---------|-----------------------------------|--------------------------------|-----------------------------|---------------------|
| 0 | Х | Х | Х | Disabled |
| 1 | No | х | х | Enabled |
| 1 | Yes | No | х | Disabled |
| 1 | Yes | Yes | No | Disabled |
| 1 | Yes | Yes | Yes | Enabled |

3.1.3.4 Latency Selection Bit (LATENCY)

The latency selection bit selects between one of two data latency methods to accommodate synchronized sampling or simultaneous sampling. Reference Section 4.5 for more information regarding latency and data synchronization.

| Latency | Data Latency | |
|---------|---|--|
| 0 | Simultaneous Sampling Mode (Latency relative to Sync Pulse) | |
| 1 | Synchronous Sampling Mode (Latency relative to Time Slot) | |

3.1.3.5 Data Size Selection Bit (DATASIZE)

The data size selection bit selects one of two data lengths for the PSI5 response message as shown below.

| DATASIZE | Data Length |
|----------|-------------|
| 0 | 10 Bits |
| 1 | 8 Bits |

3.1.3.6 PSI5 Sync Pulse Blanking Time Selection Bit (BLANKTIME)

The PSI5 sync pulse blanking time selection bit selects the timing for ignoring sync pulses after successful reception of a sync pulse. Reference Section 4.2.1.1 for details regarding sync pulse detection and blanking.

| BLANKTIME | Blanking Time Method |
|-----------|---|
| 0 | Maximum of t _{SYNC_OFF_500} or Response Transmission Complete |
| 1 | Blanking Time determined by end of response transmission for programmed time slot |



3.1.3.7 PSI5 Response Message Error Detection Selection Bit (P_CRC)

The PSI5 response message error detection selection bit selects either even parity, or a 3-Bit CRC for error detection of the PSI5 response message. Reference Section 4.3.3 for details regarding response message error detection.

| P_CRC | Parity or CRC |
|-------|---------------|
| 0 | Parity |
| 1 | CRC |

Note: The PSI5 specification recommends parity for data lengths of 10 bits or less.

3.1.3.8 Baud Rate Selection Bit (BAUD)

The baud rate selection bit selects one of two PSI5 baud rates as shown below. Reference Section 2.6 for baud rate timing specifications.

| BAUD | Baud Rate |
|------|------------------------------|
| 0 | Low Baud Rate (125 kBaud) |
| 1 | High Baud Rate (190.5 kBaud) |

3.1.4 Device Configuration Registers (DEVCFG3, DEVCFG4, DEVCFG5)

Device configuration registers 3, 4, and 5 are user programmable OTP registers which contain device configuration information.

| Loc | cation | Bit | | | | | | | |
|---------|-----------|--------------|--------------|--------------|--------------|--------------|--------------|--------------|--------------|
| Address | Register | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| \$06 | DEVCFG3 | TRANS_MD[1] | TRANS_MD[0] | LPF[1] | LPF[0] | TIMESLOTB[9] | TIMESLOTB[8] | TIMESLOTA[9] | TIMESLOTA[8] |
| \$07 | DEVCFG4 | TIMESLOTA[7] | TIMESLOTA[6] | TIMESLOTA[5] | TIMESLOTA[4] | TIMESLOTA[3] | TIMESLOTA[2] | TIMESLOTA[1] | TIMESLOTA[0] |
| \$08 | DEVCFG5 | TIMESLOTB[7] | TIMESLOTB[6] | TIMESLOTB[5] | TIMESLOTB[4] | TIMESLOTB[3] | TIMESLOTB[2] | TIMESLOTB[1] | TIMESLOTB[0] |
| Factor | y Default | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

3.1.4.1 PSI5 Transmission Mode Selection Bits (TRANS_MD[1:0])

The PSI5 transmission mode selection bits select the PSI5 transmission mode as shown below.

| TRANS_MD[1] | TRANS_MD[0] | Operating Mode | Reference |
|-------------|-------------|---|---------------|
| 0 | 0 | Normal Mode (Asynchronous or Parallel, Synchronous) | Section 4.5.1 |
| 0 | 1 | Synchronous Double Sample Rate Mode | Section 4.5.2 |
| 1 | 0 | 16-bit Resolution Mode (Two 10-bit Responses) | Section 4.5.3 |
| 1 | 1 | Daisy Chain Mode | Section 4.5.4 |

3.1.4.2 Low-Pass Filter Selection Bit (LPF[1:0])

The low-pass filter selection bits select the low-pass filter for the acceleration signal as described below:

| LPF[1] | LPF[0] | Low-Pass Filter Selected |
|--------|--------|--------------------------|
| 0 | 0 | 400 Hz, 3-Pole |
| 0 | 1 | 400 Hz, 4-Pole |
| 1 | 0 | Reserved |
| 1 | 1 | Reserved |



3.1.4.3 TimeSlot Selection Bits (TIMESLOTx[9:0])

The timeslot selection bits select the time slot(s) to be used for data transmission. Reference Section 4.5 for details regarding PSI5 transmission modes and time slots. Accepted time slot values are 0.5 μ s to 511.5 μ s in 0.5 μ s increments. Care must be taken to prevent from programming time slots which violate the PSI5 Version 1.3 specification, or time slots which will cause data contention.

| TIMESLOTx[9:0] | ASYNC Bit | Time Slot | Reference |
|----------------|-----------|---|-------------|
| 00 0000 0000 | 0 | Default Time Slot ($t_{TIMESLOT_DFLT}$) from start of Sync Pulse (t_{TRIG}) | Section 4.5 |
| 00 0000 0000 | 1 | Asynchronous Mode Section | |
| Non-Zero | N/A | TimeSlot Definition from start of Sync Pulse (t _{TRIG}) in 0.5µs Increments | |

Note: TIMESLOTB is only used for Synchronous Double Sample Rate Mode and 16-Bit Resolution Mode.

3.1.5 Device Configuration Registers 6, 7, and 8 (DEVCFG6, DEVCFG7, DEVCFG8)

Device configuration registers 6, 7 and 8 are user programmable OTP registers which contain device configuration and user specific manufacturing information. The user specific manufacturing information bits have no impact on the performance, but are transmitted during the PSI5 initialization phase 2 in 10-bit mode.

| Loca | ation | Bit | | | | | | | |
|---------|----------|-----------|----------|----------|----------|----------|----------|----------|----------|
| Address | Register | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| \$09 | DEVCFG6 | INIT2_EXT | ASYNC | U_DIR[1] | U_DIR[0] | U_REV[3] | U_REV[2] | U_REV[1] | U_REV[0] |
| \$0A | DEVCFG7 | MONTH[3] | MONTH[2] | MONTH[1] | MONTH[0] | YEAR[3] | YEAR[2] | YEAR[1] | YEAR[0] |
| \$0B | DEVCFG8 | UD[2] | UD[1] | UD[0] | DAY[4] | DAY[3] | DAY[2] | DAY[1] | DAY[0] |
| Factory | Default | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 |

3.1.5.1 Initialization Phase 2 Data Extension Bit (INIT2_EXT)

The initialization phase 2 data extension bit enables or disables data transmission in data fields D27 through D32 of PSI5 Initialization Phase 2 as shown below.

| INIT2_EXT | 2_EXT Description | | | | | |
|-----------|---|--|--|--|--|--|
| 0 | D27 through D32 are set to "0000" | | | | | |
| 1 | D27 through D32 are transmitted as defined in Section 4.4.2.1 | | | | | |

3.1.5.2 Asynchronous Mode Bit (ASYNC)

The asynchronous mode bit enables asynchronous data transmission as described in Section 3.1.4.3.

3.1.5.3 User Sensing Direction (U_DIR[1:0])

The user sensing direction registers are user programmable OTP registers which contain the module level sensing direction. This data is transmitted to the main ECU during PSI5 initialization phase 2 in 10-bit mode, as described in Section 4.4.2.1.

| U_DIR[1] | U_DIR[0] | Module Sensing Direction As Defined in AKLV27 | PSI5 Init Data Transmission (D8) Reference Table 13 |
|----------|----------|--|--|
| 0 | 0 | Connector Direction (β) | 0000 |
| 0 | 1 | Bushing Direction (α) | 0100 |
| 1 | 0 | Perpendicular to α and $\beta\left(\gamma\right)$ | 1000 |
| 1 | 1 | Not used | 1100 |

3.1.5.4 User Product Revision (U_REV[3:0])

The user product revision registers are user programmable OTP registers which contain the module production revision. The device supports up to 16 product revisions. This data is transmitted to the main ECU during PSI5 initialization phase 2 in 10-bit mode, as described in Section 4.4.2.1.



3.1.5.5 User Production Date Information (YEAR[3:0], MONTH[3:0], DAY[4:0)

The user production date information registers are user programmable OTP registers which contain the module production date. The table below shows the relationship between the stored values and the production date.

| Programmed Value | Decoded Value | Julian Date Value |
|------------------|---------------|-------------------|
| YEAR[3:0] | Year | JY[6:0] |
| 0000 | 2009 | 0001001 |
| • | • | • |
| • | • | • |
| 1111 | 2024 | 0011000 |
| MONTH[3:0] | Month | JM[3:0] |
| 0000 | N/A | 0000 |
| 0001 | January | 0001 |
| • | • | • |
| • | • | • |
| 1100 | December | 1100 |
| • | • | • |
| • | • | • |
| 1111 | N/A | N/A |
| DAY[4:0] | Day | JD[4:0] |
| 00000 | N/A | 00000 |
| 00001 | Day 1 | 00001 |
| • | • | • |
| • | • | • |
| 11111 | Day 31 | 11111 |

The Julian date value is transmitted to the main ECU during PSI5 initialization phase 2 in 10-bit mode, as described in Section 4.4.2.1.

3.1.5.6 User Specific Data (UD[2:0])

The user specific data bits are user programmable OTP bits. These bits have no impact on device operation or performance.



3.1.6 Status Check Register (SC)

The status check register is a read-only register containing device status information.

| Loca | ation | | Bit | | | | | | |
|---------|----------|---|------|----------|--------|-----------|--------|-------|---|
| Address | Register | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 |
| \$0C | SC | 0 | TM_B | RESERVED | IDEN_B | OC_INIT_B | IDEF_B | OFF_B | 1 |

3.1.6.1 Test Mode Flag (TM_B)

The test mode bit is cleared if the device is in test mode.

| ТМ_В | Operating Mode |
|------|-------------------------|
| 0 | Test Mode is active |
| 1 | Test Mode is not active |

3.1.6.2 Internal Data Error Flag (IDEN_B)

The internal data error bit is cleared if a register data error detection mismatch is detected in the user accessible OTP array. A device reset is required to clear the error.

| IDEN_B | Error Condition |
|--------|---|
| 0 | Error detection mismatch in user programmable OTP array |
| 1 | No error detected |

3.1.6.3 Offset Cancellation Init Status Flag (OC_INIT_B)

The offset cancellation initialization status bit is set once the offset cancellation initialization process is complete, and the filter has switched to normal mode.

| OC_INIT_B | Error Condition | | | | | |
|-----------|--|--|--|--|--|--|
| 0 | Offset Cancellation in initialization | | | | | |
| 1 | Offset Cancellation initialization complete (t_{OC1} and t_{OC2} expired) | | | | | |

3.1.6.4 Internal Factory Data Error Flag (IDEF_B)

The internal factory data error bit is cleared if a register data CRC fault is detected in the factory programmable OTP array. A device reset is required to clear the error.

| IDEF_B | Error Condition | | | |
|--------|---|--|--|--|
| 0 | CRC error in factory programmable OTP array | | | |
| 1 | No error detected | | | |

3.1.6.5 Offset Error Flag (OFF_B)

The offset error flag is cleared if the acceleration signal reaches the offset limit.

| OFF_B | Error Condition | | | |
|-------|-----------------------|--|--|--|
| 0 | Offset error detected | | | |
| 1 | No error detected | | | |



3.1.7 Manufacturer ID (MFG_ID)

The manufacturer ID register is a user programmable OTP register that contains the PSI5 manufacturer ID. The manufacturer ID register has no impact on the performance, but is transmitted during the PSI5 initialization phase 2 in 10-bit mode.

| Location | | Bit | | | | | | | | |
|-----------------|----------|-----------|-----------|-----------|-----------|-----------|-----------|-----------|-----------|--|
| Address | Register | 7 | 6 | 5 | 4 | 3 | 2 | 1 | 0 | |
| \$0D | MFG_ID | MFG_ID[7] | MFG_ID[6] | MFG_ID[5] | MFG_ID[5] | MFG_ID[3] | MFG_ID[2] | MFG_ID[1] | MFG_ID[0] | |
| Factory Default | | 0 | 0 | 0 | 0 | 0 | 0 | 0 | 0 | |

3.2 OTP Array CRC Verification

3.2.1 Factory Programmed OTP Array CRC Verification

The Factory programmed OTP array is verified for errors with a 3-bit CRC. The CRC verification is enabled only when the factory programmed array is locked. The CRC verification uses a generator polynomial of $g(x) = X^3 + X + 1$, with a seed value = '111'.

Once the CRC verification is enabled, the CRC is continuously calculated on all bits in registers \$00, \$01, \$02, \$03, and \$04 and on the factory programmable device configuration bits with the exception of the factory lock bit. Bits are fed in from right to left (LSB first), and top to bottom (lower addresses first) in the register map. The calculated CRC is then compared against the stored 3 bit CRC. If a CRC error is detected in the OTP array, the IDEF_B bit is cleared in the SC register.

The CRC verification is completed on the memory registers which hold a copy of the fuse array values, not the fuse array values.

3.2.2 User Programmable OTP Array Error Detection

The user programmable OTP array is independently verified for errors. The Error Detection is enabled only when the LOCK_U bit in the user data register array is set.

When a PSI5 Programming Mode "Execute Programming of NVM" command is received and the LOCK_U bit is set, the device calculates the error detection code and writes the code to NVM, enabling the Error Detection.

Once the error detection is enabled, the error detection code is continuously calculated on all bits in registers \$05, \$06, \$07, \$08, \$09, \$0A, \$0B and \$0D with the exception of the LOCK_U bit. The calculated code is then compared against the stored error code. If a mismatch is detected, the IDEN_B bit is cleared in the SC register.

The error detection is completed on the memory registers which hold a copy of the fuse array values, not the fuse array values.



3.3 Voltage Regulators

The device derives its internal supply voltage from the V_{CC} and V_{SS} pins. Separate internal voltage regulators are used for the analog (V_{REGA}) and digital circuitry (V_{REG}). The analog and digital regulators are supplied by a buffer regulator (V_{BUF}) to provide immunity from EMC and supply dropouts on V_{CC}. External filter capacitors are required, as shown in Figure 1.

The voltage regulator module includes voltage monitoring circuitry which holds the device in reset following power-on until the internal voltages have increased above the under-voltage detection thresholds. The voltage monitor asserts internal reset when the external supply or internally regulated voltages fall below the under-voltage detection thresholds. A reference generator provides a reference voltage for the $\Sigma\Delta$ converter.

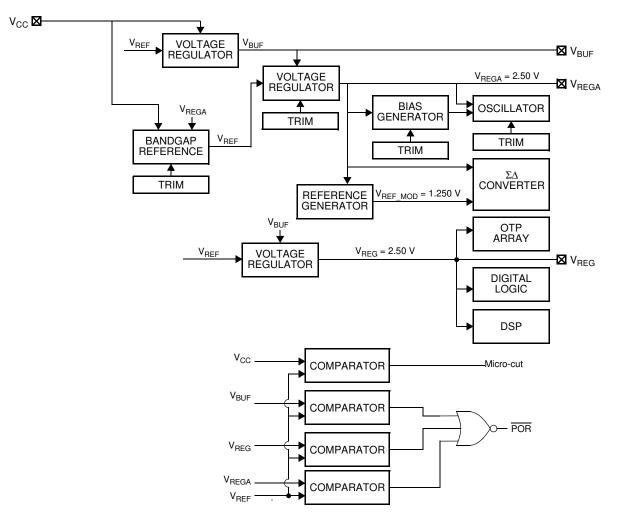


Figure 8. Voltage Regulation and Monitoring



3.3.1 V_{BUF}, V_{REG}, and V_{REGA} Regulator Capacitor

The internal regulators require an external capacitor between each of the regulator pins (V_{BUF} , V_{REG} , or V_{REGA}) and the associated the V_{SS} / V_{SSA} pin for stability. Figure 1 shows the recommended types and values for each of these capacitors.

3.3.2 V_{CC}, V_{BUF}, V_{REG}, and V_{REGA} Under-Voltage Monitor

A circuit is incorporated to monitor the supply voltage (V_{CC}) and all internally regulated voltages (V_{BUF} , V_{REG} , and V_{REGA}). If any of internal regulator voltages fall below the specified under-voltage thresholds in Section 2, the device will be reset. If V_{CC} falls below the specified threshold, PSI5 transmissions are terminated for the present response. Once the supply returns above the threshold, the device will respond to the next detected sync pulse. Reference Figure 9.

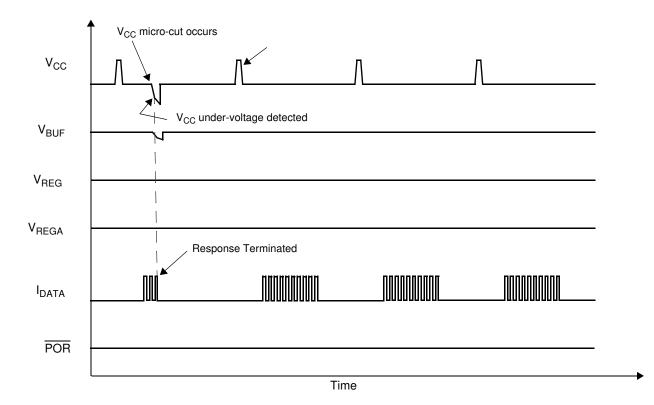


Figure 9. V_{CC} Micro-Cut Response



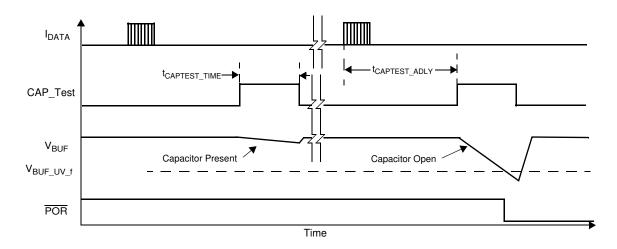
3.3.3 V_{BUF}, V_{REG}, and V_{REGA} Capacitance Monitor

A monitor circuit is incorporated to ensure predictable operation if the connection to the external V_{BUF} , V_{REG} , or V_{REGA} , capacitor becomes open.

In asynchronous mode, the V_{BUF} regulator is disabled $t_{CAPTEST_ADLY}$ seconds after each data transmission for a duration of $t_{CAPTEST_TIME}$ seconds. If the external capacitor is not present, the regulator voltage will fall below the internal reset threshold, forcing a device reset.

In synchronous mode, the V_{BUF} regulator is disabled $t_{CAPTEST_SDLY}$ seconds after each sync pulse for a duration of $t_{CAPTEST_TIME}$ seconds. If the external capacitor is not present, the regulator voltage will fall below the internal reset threshold, forcing a device reset.

The V_{REG} and V_{REGA} regulators are disabled at a continuous rate (t_{CAPTEST_RATE), for a duration of t_{CAPTEST_TIME} seconds. If either external capacitor is not present, the associated regulator voltage will fall below the internal reset threshold, forcing a device reset.





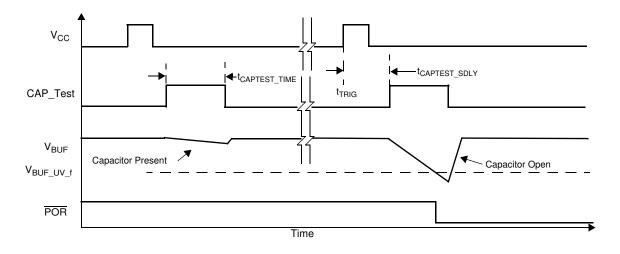
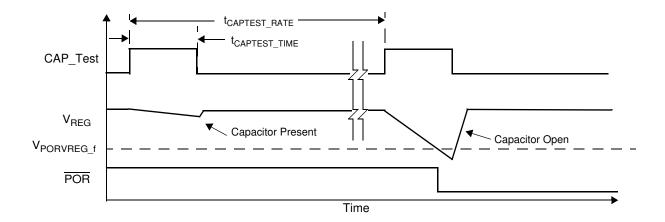
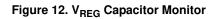


Figure 11. V_{BUF} Capacitor Monitor - Synchronous Mode







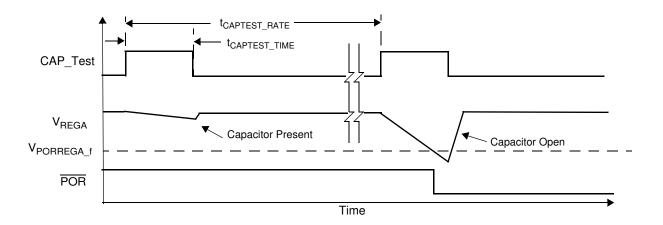


Figure 13. V_{REGA} Capacitor Monitor

3.4 Internal Oscillator

A factory trimmed oscillator is included as specified in Section 2.



3.5 Acceleration Signal Path

3.5.1 Transducer

The transducer is an overdamped mass-spring-damper system defined by the following transfer function: where:

$$H(s) = \frac{\omega_n^2}{s^2 + 2 \cdot \xi \cdot \omega_n \cdot s + \omega_n^2}$$

 ζ = Damping Ratio

 ω_n = Natural Frequency = 2 * $\Pi * f_n$

Reference Section 2.7 for transducer parameters.

3.5.2 $\Sigma \Delta$ Converter

A sigma delta modulator converts the differential capacitance of the transducer to a 1 MHz data stream that is input to the DSP block.

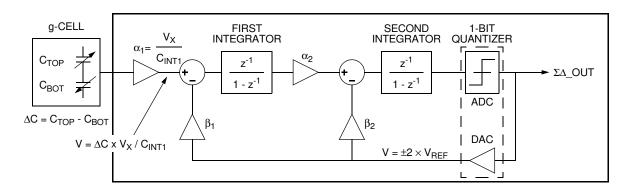


Figure 14. $\Sigma\Delta$ Converter Block Diagram

3.5.3 Digital Signal Processing Block

A Digital Signal Processing (DSP) block is used to perform signal filtering and compensation. A diagram illustrating the signal processing flow within the DSP block is shown in Figure 15.

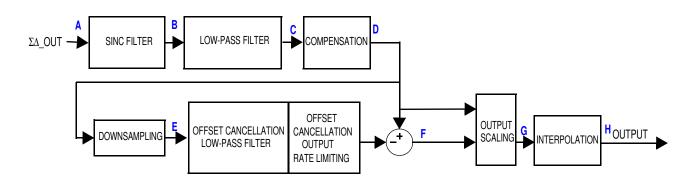


Figure 15. Signal Chain Diagram